

**Notice of References Cited**

Application/Control No.: 10/090,469

Applicant(s)/Patent Under  
Reexamination  
JANG ET AL.Examiner  
David DunnArt Unit  
3616

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,944,342	08-1999	White et al.	280/729
B	US-6,062,594	05-2000	Asano et al.	280/730.2
C	US-6,106,004	08-2000	Heinz et al.	280/729
D	US-6,199,898	03-2001	Masuda et al.	280/730.2
E	US-6,270,113	08-2001	Wipasuramonton et al.	280/730.2
F	US-6,273,456	08-2001	Heigl, Jurgen	280/730.2
G	US-6,279,944	08-2001	Wipasuramonton et al.	280/730.2
H	US-6,371,518	04-2002	Kalandek et al.	280/743.1
I	US-6,478,329	11-2002	Yokoyama, Aki	280/729
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
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T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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